Comparative study of structural and optical properties of zirconium-doped indium oxide synthesized by solid state reactions and sol-gel technique

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Abstract. In the present work the effect of zirconium doping (1.5 at.%) on the structural and optical properties of indium zirconium oxide was studied. Zr-doped indium oxides were prepared by using two different methods, solid state reactions and sol-gel technique. The compositions with bixbyite structure have been synthesized by two different methods, solid state reactions in air and sol-gel process. X-ray powder diffraction (XRPD) used for phases analysis confirm the validity of the cubic bixbyite-type structure of In₂O₃. The optical properties of the prepared composition were considered in terms of their diffuse reflectance spectra (DRS). The morphology of crystals was evidenced by SEM analyses and reveal agglomeration of particles with their size ranges in the micrometer domain.

Introduction

Transparent conducting oxides (TCOs) are an important class of materials which have attracted much attention in the last years due to their main properties, low resistivity and high optical transparency. The dominant TCOs are mainly zinc oxide (ZnO), indium oxide (In₂O₃) and tin oxide (SnO₂), as well as subsequent mixtures of these, such as well-known indium tin oxide (ITO) [1]. In₂O₃, a wide-bandgap n-type semiconductor, is widely used in various applications due to their properties including solar applications, the transparent electrodes in various optoelectronic devices, the flat panel liquid crystals displays, the barrier layers in tunnel junctions, the active layers of gas sensors or the material for ultraviolet lasers [2]. Therefore, the physical properties of the In₂O₃, like high electrical conductivity and optical transparency in the visible range, strongly depend on the preparation method. For this reason there are many investigations which are studying their properties in dependence on the synthesis methods. These methods include physical methods such as sputtering, evaporation, pulsed laser deposition, spray pyrolysis, as well as chemical methods like chemical pyrolysis, chemical vapor deposition, sol-gel, bath deposition and electroplating [3–8]. On the other hand electrical properties of In₂O₃ can be improved by doping with metallic donor impurity. For this reason the system ZrO₂–In₂O₃ was mostly investigated [8-10].
In the present paper we comparatively investigated the structural evolution, optical and morphological properties of indium zirconium oxide prepared by two methods, solid state synthesis and sol-gel route.

**Materials and Methods**

**Synthesis**

Two different preparation methods were employed in the synthesis of zirconium-doped indium oxide: solid state synthesis and sol-gel method.

Compositions belonging to $\text{In}_2\text{O}_3 \left(0.025 \leq x \leq 0.15\right)$ system with the bixbyite structure were prepared by solid state reactions from mixtures of pure $\text{In}_2\text{O}_3$ (Alfa Aesar 99.995%) and $\text{ZrO}_2$ (Alfa Aesar 99%) at 1400 °C, in air.

In the sol-gel synthesis indium (III) nitrate hydrate ($\text{In(NO}_3\text{)}_2\cdot x\text{H}_2\text{O}$) was used as a precursor and zirconium (IV) chloride ($\text{ZrCl}_4$) as a doping source at the molar ratios required to obtain $\text{In}_2\text{O}_3$ doped with 1.5 at % ZrO$_2$. Aqueous solutions of the two salts were stirred on a warming plate at 80 °C in order to mix the solution uniformly. The sol was prepared using isopropyl alcohol as solvent and ethylene glycol or sucrose as polymerization agent. The sucrose solution was added gradually into the aqueous solutions under stirring until colloidal suspensions were obtained. The sol continuously transformed into wet gel and then dried gel under heating at 100 °C during 24h. The resulted dried materials were annealed at 600 °C in air for one hour to form the required Zr-doped indium oxide. Fig. 1 presents schematic flow chart of indium zirconium oxide obtained by solid state synthesis.

![Diagram](image)

**Fig. 1.** Schematic flow chart of indium zirconium oxide obtained by solid state synthesis.

**Characterization Methods**

The X-ray powder diffraction (XRPD) data were collected in the $2\theta = 10$-$80^\circ$ angular domain with a Bruker D8 Advance diffractometer, using CuKα1 radiation (40 kV; 40 mA).
Optical properties were investigated using a Jasco V-650 spectrophotometer (Japan) equipped with an ISV-722 Integrating Sphere. The diffuse reflectance spectra (DRS) were recorded in the range 200-800 nm with a scan rate of 400 nm/min.

The samples morphology was investigated using a Hitachi SU8230 Scanning Electron Microscope (SEM).

Results and discussion

X-ray powder diffraction (XRPD) analysis

The X-ray diffraction patterns of zirconium doped In₂O₃ prepared by solid state reaction with different concentrations are shown in Fig. 2. All samples showed similar XRPD patterns, indicating the high crystallinity of our bulk materials. No extra peaks are observed due to the addition of zirconium in indium oxide films which indicates the absence of an impurity phase in the prepared samples.

![Fig. 2. XRPD patterns of In₂₋ₓZrxO₃ (0.025 ≤ x ≤ 0.15) system prepared by solid state reaction.](image)

![Fig. 3. XRPD patterns of x = 0.075 composition prepared by solid state reaction (a) and sol-gel method using (b) isopropyl alcohol, (c) sucrose or (d) ethylene glycol.](image)
There are four prominent peaks as shown in Fig. 2, which can be indexed to the (222), (400), (440) and (622) crystal planes of the In$_2$O$_3$ cubic structure. XRPD of $x = 0.075$ sample prepared via sol-gel route and solid state reaction are presented comparatively in Fig. 3. From the figure, it was clear that the intensity of peaks is increased in the $x = 0.075$ composition prepared by solid state reaction. The increase in intensity of the peaks is due to the improvement of sample crystallinity.

**UV-VIS spectroscopy analysis**

Fig. 4 show the difusse reflectance spectra (DRS) of zirconium doped In$_2$O$_3$ prepared by sol-gel method using isopropyl alcohol as solvent and ethylene glycol or sucrose as polymerization agent. The maximum percent reflectance around 450 nm, observed for sample prepared using sucrose, is increasing for samples prepared using isopropyl alcohol as solvent and ethylene glycol as polymerization agent. Simultaneously, a shift of the optical bandgap to higher wavelengths occurs. The reflectance spectra of $x = 0.075$ composition prepared by solid state reaction and sol-gel method using sucrose are displayed comparatively in Fig. 5. One indeed observes that sol-gel preparation of zirconium doped indium oxide decreases the maximum percent reflectance around 450 nm, by approximately 20%, with respect to same composition prepared by solid state reaction.

![Fig. 4. Measured DRS in the compositions $x = 0.075$ prepared by sol-gel method using (a) isopropyl alcohol, (b) sucrose or (c) ethylene glycol.](image)

![Fig. 5. Measured DRS in the composition $x = 0.075$ prepared by solid state reactions (a) and sol-gel method using sucrose (b).](image)
SEM microscopy analysis

Scanning electron microscopy (SEM) was used to study the particle morphology of the studied samples. SEM images of the samples recorded for $x = 0.075$ composition prepared by solid state reaction and sol-gel route are shown in Fig. 6. Smooth surface and uniform distribution of grain are observed for composition synthesized by solid state reaction (Fig. 6 a).

Fig. 6. SEM images at x100 (up) and x10.0k (down) magnification of $x = 0.075$ composition prepared by solid state reaction (a) and sol-gel method using (b) isopropyl alcohol, (c) sucrose or (d) ethylene glycol.
Particles with an angular shape are observed for the sol-gel synthesized samples using sucrose or ethylene glycol, as seen in Fig. 6c and 6d. The micrographs of zirconium indium oxide prepared by sol-gel with isopropyl alcohol as solvent (Fig. 6b) showed agglomeration of the particles. In all the cases the size of grains is situated in the micrometer range.

Conclusions

Structural evolution of the bulk materials in the candidate TCOs zirconium-doped indium oxide prepared by solid state reaction at high temperature and the sol-gel method were investigated. XRPD analysis shows that cubic bixbyite structure was confirmed with pure phases obtained in all the prepared samples. Measured diffuse reflectance spectra (DRS) show a decrease of max. %R for compositions prepared by the sol-gel method; moreover the sucrose addition as polymerization agent improve the optical properties. The surface morphology of the all prepared samples appears homogeneous and consists of small grains with size ranges in the micrometer domain.

References